

## MOS FIELD EFFECT TRANSISTOR

2SK3353

# SWITCHING N-CHANNEL POWER MOS FET

### **DESCRIPTION**

The 2SK3353 is N-channel MOS Field Effect Transistor designed for high current switching applications.

### **FEATURES**

• Super low on-state resistance:

 $R_{DS(on)1} = 9.5 \, m\Omega \, MAX. \, (V_{GS} = 10 \, V, \, I_{D} = 41 \, A)$   $R_{DS(on)2} = 14 \, m\Omega \, MAX. \, (V_{GS} = 4 \, V, \, I_{D} = 41 \, A)$ 

- Low Ciss: Ciss = 4650 pF TYP.
- Built-in gate protection diode

### **ORDERING INFORMATION**

| PART NUMBER | PACKAGE                   |
|-------------|---------------------------|
| 2SK3353     | TO-220AB                  |
| 2SK3353-S   | TO-262                    |
| 2SK3353-ZJ  | TO-263                    |
| 2SK3353-Z   | TO-220SMD <sup>Note</sup> |

**Note** TO-220SMD package is produced only in Japan

(TO-220AB)

### ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

| Drain to Source Voltage (Vss = 0 V)             | VDSS               | 60          | V  |
|---|--------------------|-------------|----|
| Gate to Source Voltage (Vps = 0 V)              | Vgss               | ±20         | V  |
| Drain Current (DC) (Tc = 25°C)                  | I <sub>D(DC)</sub> | ±82         | Α  |
| Drain Current (pulse) Note1                     | D(pulse)           | ±328        | Α  |
| Total Power Dissipation (Tc = 25°C)             | $\mathbf{P}_{T}$   | 95          | W  |
| Total Power Dissipation (T <sub>A</sub> = 25°C) | $\mathbf{P}_{T}$   | 1.5         | W  |
| Channel Temperature                             | $T_ch$             | 150         | °C |
| Storage Temperature                             | $T_{stg}$          | -55 to +150 | °C |
| Single Avalanche Current Note2                  | las                | 45          | Α  |
| Single Avalanche Energy Note2                   | Eas                | 202         | mJ |

**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty cycle  $\leq$  1%

**2.** Starting T<sub>ch</sub> = 25°C, V<sub>DD</sub> = 30 V, R<sub>G</sub> = 25  $\Omega$ , V<sub>GS</sub> = 20  $\rightarrow$  0 V



(TO-262)



(TO-263, TO-220SMD)



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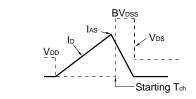


### **ELECTRICAL CHARACTERISTICS (TA = 25°C)**

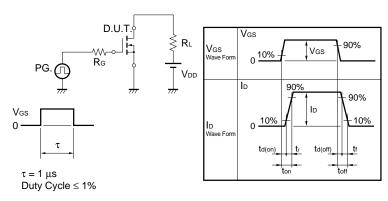
| Characteristics                     | Symbol               | Test Conditions                               | MIN. | TYP. | MAX. | Unit      |
|-------------------------------------|----------------------|---|------|------|------|-----------|
| Zero Gate Voltage Drain Current     | IDSS                 | V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V |      |      | 10   | μА        |
| Gate Leakage Current                | lgss                 | Vgs = ±20 V, Vps = 0 V                        |      |      | ±10  | μΑ        |
| Gate Cut-off Voltage                | V <sub>GS(off)</sub> | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA | 1.5  | 2.0  | 2.5  | V         |
| Forward Transfer Admittance         | Yfs                  | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 41 A | 30   | 50   |      | S         |
| Drain to Source On-state Resistance | RDS(on)1             | VGS = 10 V, ID = 41 A                         |      | 7.5  | 9.5  | $m\Omega$ |
|                                     | RDS(on)2             | Vgs = 4V, ID = 41 A                           |      | 10.5 | 14   | mΩ        |
| Input Capacitance                   | Ciss                 | Vps = 10 V                                    |      | 4650 |      | pF        |
| Output Capacitance                  | Coss                 | V <sub>G</sub> S = 0 V                        |      | 780  |      | pF        |
| Reverse Transfer Capacitance        | Crss                 | f = 1 MHz                                     |      | 380  |      | pF        |
| Turn-on Delay Time                  | td(on)               | V <sub>DD</sub> = 30 V, I <sub>D</sub> = 41 A |      | 100  |      | ns        |
| Rise Time                           | tr                   | V <sub>GS</sub> = 10 V                        |      | 1550 |      | ns        |
| Turn-off Delay Time                 | td(off)              | $R_G = 10 \Omega$                             |      | 280  |      | ns        |
| Fall Time                           | tf                   |   |      | 420  |      | ns        |
| Total Gate Charge                   | Q <sub>G</sub>       | V <sub>DD</sub> = 48 V                        |      | 90   |      | nC        |
| Gate to Source Charge               | Qgs                  | V <sub>GS</sub> = 10 V                        |      | 14   |      | nC        |
| Gate to Drain Charge                | Q <sub>GD</sub>      | ID = 82 A                                     |      | 24   |      | nC        |
| Body Diode Forward Voltage          | VF(S-D)              | IF = 82 A, VGS = 0 V                          |      | 1.0  |      | V         |
| Reverse Recovery Time               | trr                  | IF = 82 A, VGS = 0 V                          |      | 60   |      | ns        |
| Reverse Recovery Charge             | Qrr                  | di/dt = 100 A/μs                              |      | 110  |      | nC        |

### **TEST CIRCUIT 1 AVALANCHE CAPABILITY**

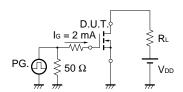
# $\begin{array}{c} \text{D.U.T.} \\ \text{Rg} = 25 \ \Omega \\ \text{VGs} = 20 \rightarrow 0 \ V \end{array}$



### TEST CIRCUIT 2 SWITCHING TIME

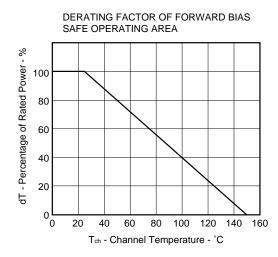


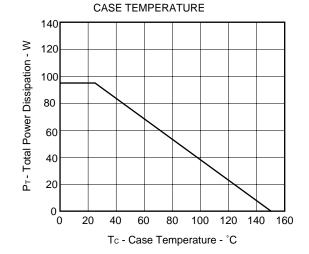
### **TEST CIRCUIT 3 GATE CHARGE**



### TYPICAL CHARACTERISTICS (TA = 25°C)

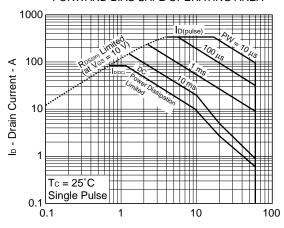
**NEC** 



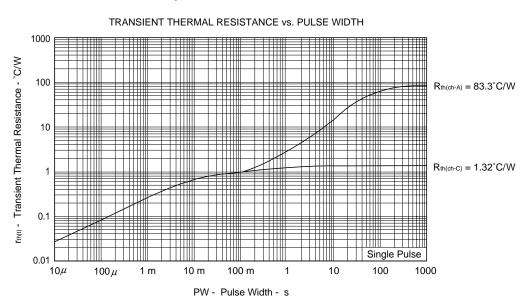


TOTAL POWER DISSIPATION vs.

### FORWARD BIAS SAFE OPERATING AREA

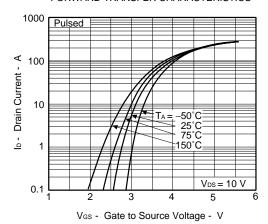


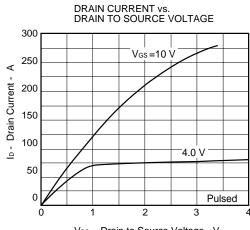
V<sub>DS</sub> - Drain to Source Voltage - V



3

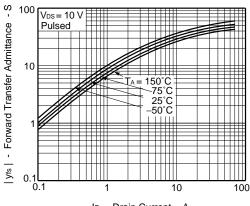
### FORWARD TRANSFER CHARACTERISTICS





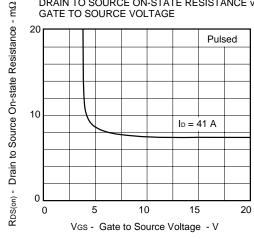
V<sub>DS</sub> - Drain to Source Voltage - V

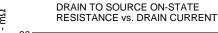
### FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

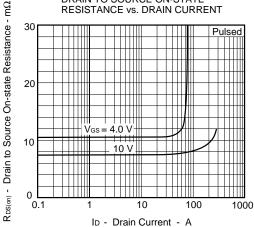


ID - Drain Current - A

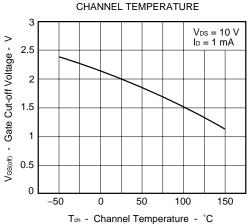
### DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



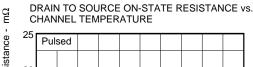


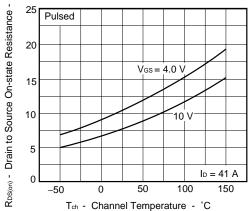


GATE CUT-OFF VOLTAGE vs.

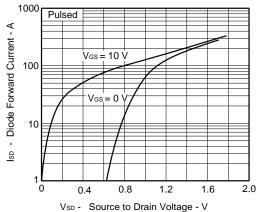




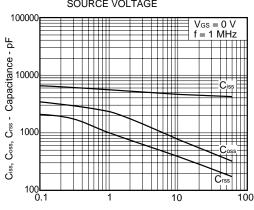




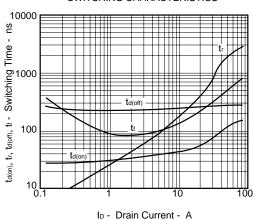
### SOURCE TO DRAIN DIODE FORWARD VOLTAGE



### CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE

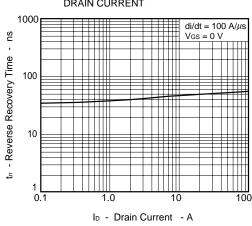


### SWITCHING CHARACTERISTICS

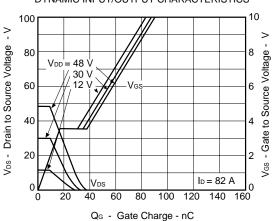


# REVERSE RECOVERY TIME vs. DRAIN CURRENT

 $V_{\text{\scriptsize DS}}$  - Drain to Source Voltage - V



### DYNAMIC INPUT/OUTPUT CHARACTERISTICS



5

# SINGLE AVALANCHE CURRENT vs. INDUCTIVE LOAD 1000 V: tuesday 100 IAs = 45AVideo = 30VRG = $25 \Omega$ Vise = $20 \rightarrow 0V$

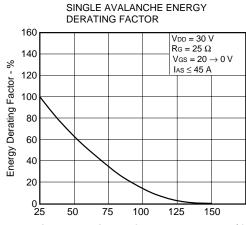
L - Inductive Load - H

1 m

10 m

100 μ

10*μ* 

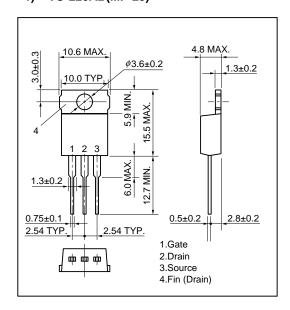


Starting Tch - Starting Channel Temperature - °C

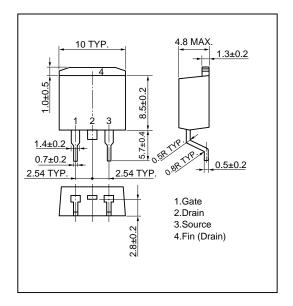


### **★ PACKAGE DRAWINGS (Unit: mm)**

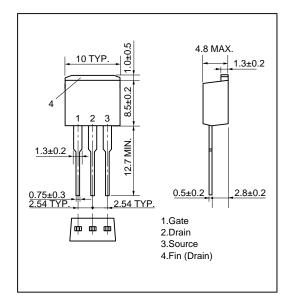
### 1) TO-220AB(MP-25)



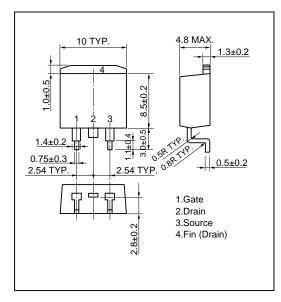
### 3) TO-263 (MP-25ZJ)



### 2) TO-262(MP-25 Fin Cut)

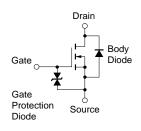


### 4) TO-220SMD (MP-25Z)<sup>Note</sup>



**Note** This package is produced only in Japan.

### **EQUIVALENT CIRCUIT**



### Remark

The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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